


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583705	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAI, SEIICHIRO
	<b>Examiner</b>  ATIF H CHAUDRY	<b>Art Unit</b>  3753

SEARCHED			
Class	Subclass	Date	Examiner
137	264,571,573,574,576	4/21/2010	ahc
220	567.1	4/21/2010	ahc
405	43,45	4/21/2010	ahc
137	236.1	7/1/2011	ahc

SEARCH NOTES		
Search Notes	Date	Examiner
See East history for inventor and citation search	4/21/2010	ahc
updated search	10/9/2010	ahc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
137	236.1,264,571,573,574,576	7/1/2011	ahc
220	567.1	7/1/2011	ahc
405	43,45	7/1/2011	ahc
	See attached interference search report	7/1/2011	ahc

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